


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537501	<b>Applicant(s)/Patent Under Reexamination</b>  HEUER ET AL.
	<b>Examiner</b>  WILSON TSUI	<b>Art Unit</b>  2178

SEARCHED			
Class	Subclass	Date	Examiner
715	234, 237, 242	04/23/09	/WT/
370	394	04/23/09	/WT/

SEARCH NOTES		
Search Notes	Date	Examiner
Updated East Search: USPAT, USPGPUB See Notes	04/23/09	/WT/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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